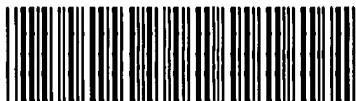


**Search Notes**

Application/Control No.

10/510,400

Examiner

Henok G. Heyi

Applicant(s)/Patent under  
Reexamination

SHIONO ET AL.

Art Unit

2627

**SEARCHED**

Class	Subclass	Date	Examiner
369	275.1	10/1/2007	HH
369	275.2	10/1/2007	HH
369	94	10/1/2007	HH
369	288	10/1/2007	HH
369	286	10/1/2007	HH
369	284	10/1/2007	HH
430	290	10/1/2007	HH

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
369	275.2	10/1/2007	HH
369	288	10/1/2007	HH
430	290	10/1/2007	HH

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST searched. See Printout. ISR was relied on. Consulted primary examiners in QEM meeting	10/1/2007	HH